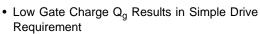


SSF65R950S-VB Datasheet

N-Channel 650V (D-S) Super Junction Power MOSFET

PRODUCT SUMM	PRODUCT SUMMARY				
V _{DS} (V)	650)			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	0.95			
Q _g (Max.) (nC)	15				
Q _{gs} (nC)	3				
Q _{gd} (nC)	6				
Configuration	Sing	le			

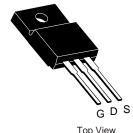
FEATURES



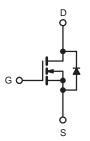


- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS directive 2002/95/EC









N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherv	vise noted		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V_{DS}	650	V
Gate-Source Voltage			V_{GS}	± 30	7 v
Continuous Drain Current ^e	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	-	5	
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	I _D	4	Α
Pulsed Drain Current ^a			I _{DM}	16	
Linear Derating Factor				1.67/0.8/0.3	W/°C
Single Pulse Avalanche Energy ^b		E _{AS}	120	mJ	
Repetitive Avalanche Current ^a		I _{AR}	34	Α	
Repetitive Avalanche Energy ^a			E _{AR}	17	mJ
Maximum Power Dissipation T _C = 25 °C		P_{D}	205/35/30	W	
Peak Diode Recovery dV/dt ^c		dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range	9		T_J,T_stg	- 55 to + 150	သံ
Soldering Recommendations (Peak Temperature)d	for	10 s		300	
Mounting Torque	6-32 or I	M3 screw		10	lbf ⋅ in
Mounting Forque	6-32 or M3 screw			1.1	N · m

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T $_J$ = 25 °C, L = 24 mH, R $_G$ = 25 Ω , I $_{AS}$ = 3.2 A (see fig. 12). c. I $_{SD}$ ≤ 3.2 A, dl/dt ≤ 90 A/ μ s, V $_{DD}$ ≤ V $_{DS}$, T $_J$ ≤ 150 °C.

- d. 1.6 mm from case.
- e. Drain current limited by maximum junction temperature.



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.6/1.2/0.6	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA ^d	-	0.6	-	mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 30 V	ı	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 520 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125 ^{\circ}\text{C}$		-	10 100	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 2.5 A ^b	-	0.95	-	Ω
Forward Transconductance	9 _{fs}	V _{DS}	= 50 V, I _D = 2.5 A	8	-	-	S
Dynamic		1					<u> </u>
Input Capacitance	C _{iss}	$V_{GS} = 0 V$		-	320	-	
Output Capacitance	C _{oss}		$V_{DS} = 25 \text{ V},$		75	-	
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	4	-	- - pF -
Output Canacitanas	C _{oss}		V _{DS} = 1.0 V, f = 1.0 MHz	-	500	-	
Output Capacitance		$V_{GS} = 0 V$	V _{DS} = 520 V, f = 1.0 MHz	-	83	-	
Effective Output Capacitance	Coss eff.		V _{DS} = 0 V to 520 V ^c	ı	14	-	
Total Gate Charge	Q_g		I _D = 2.5 A, V _{DS} = 400 V see fig. 6 and 13 ^b		-	15	nC
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V		-	-	3	
Gate-Drain Charge	Q_{gd}			-	-	6	
Turn-On Delay Time	t _{d(on)}	1		-	18	-	ns
Rise Time	t _r		$V_{DD} = 325 \text{ V}, I_D = 3.2 \text{ A}$ $R_G = 9.1 \Omega, R_D = 62 \Omega,$ see fig. 10 ^b		40	-	
Turn-Off Delay Time	t _{d(off)}	$R_{G} =$			50	-	
Fall Time	t _f	9. 1. <u></u>		-	30	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	showing the	MOSFET symbol showing the integral reverse p - n junction diode		-	5	- A
Pulsed Diode Forward Current ^a	I _{SM}				-	16	
Body Diode Voltage	V_{SD}	T _J = 25 °C	$T_J = 25 ^{\circ}\text{C}, I_S = 3.2 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 3.2 A, dI/dt = 100 A/μs ^b		-	180	-	ns
Body Diode Reverse Recovery Charge	Q_{rr}			-	2.1	3.2	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.
- c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .
- d. t = 60 s, f = 60 Hz.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

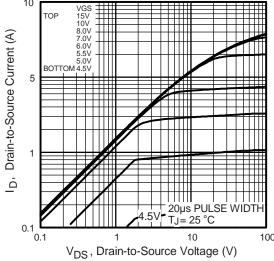


Fig. 1 - Typical Output Characteristics

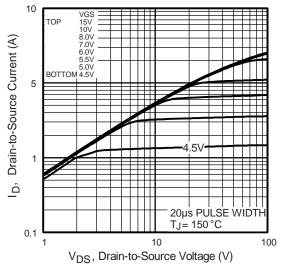


Fig. 2 - Typical Output Characteristics

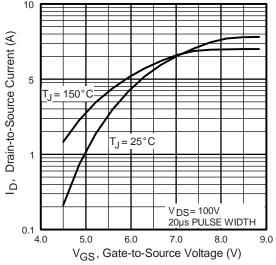


Fig. 3 - Typical Transfer Characteristics

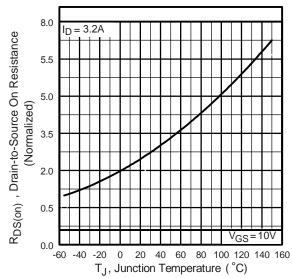


Fig. 4 - Normalized On-Resistance vs. Temperature



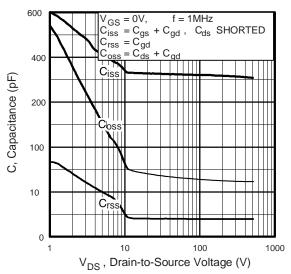


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

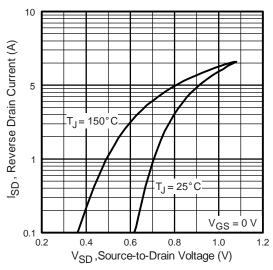


Fig. 7 - Typical Source-Drain Diode Forward Voltage

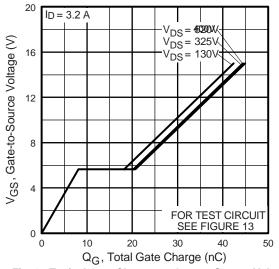


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

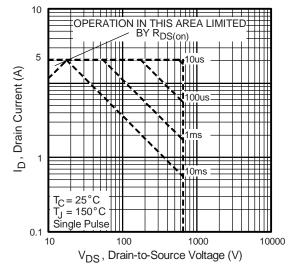


Fig. 8 - Maximum Safe Operating Area



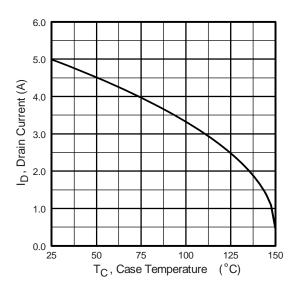


Fig. 9 - Maximum Drain Current vs. Case Temperature

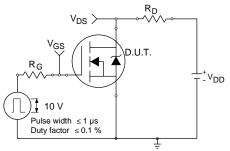


Fig. 10a - Switching Time Test Circuit

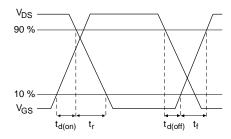


Fig. 10b - Switching Time Waveforms

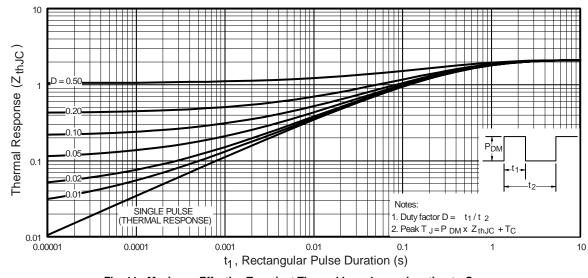


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

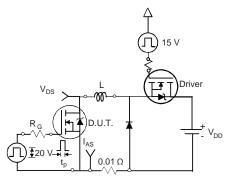


Fig. 12a - Unclamped Inductive Test Circuit

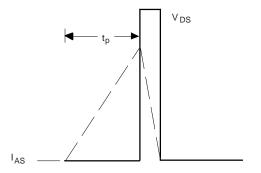


Fig. 12b - Unclamped Inductive Waveforms



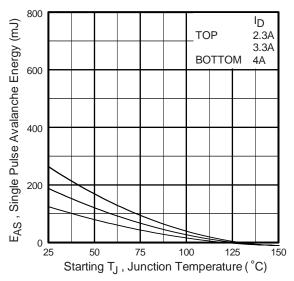


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

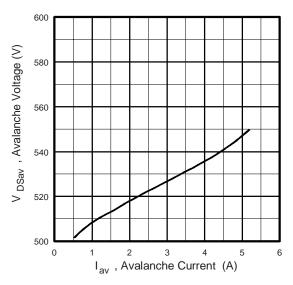


Fig. 12d - Typical Drain-to Source Voltage vs. Avalanche Current

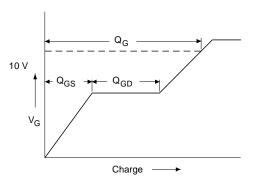


Fig. 13a - Basic Gate Charge Waveform

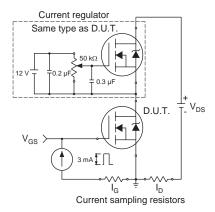
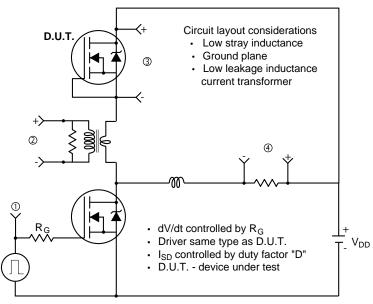


Fig. 13b - Gate Charge Test Circuit



7

Peak Diode Recovery dV/dt Test Circuit



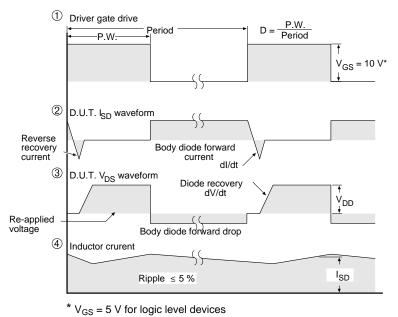
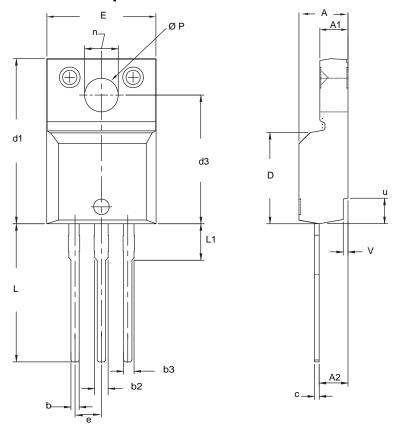


Fig. 14 - For N-Channel



TO-220 FULLPAK (HIGH VOLTAGE)



DIM.	MILLIN	METERS	INC	HES
	MIN.	MAX.	MIN.	MAX.
Α	4.570	4.830	0.180	0.190
A1	2.570	2.830	0.101	0.111
A2	2.510	2.850	0.099	0.112
b	0.622	0.890	0.024	0.035
b2	1.229	1.400	0.048	0.055
b3	1.229	1.400	0.048	0.055
С	0.440	0.629	0.017	0.025
D	8.650	9.800	0.341	0.386
d1	15.88	16.120	0.622	0.635
d3	12.300	12.920	0.484	0.509
Е	10.360	10.630	0.408	0.419
е	2.54	BSC	0.100	BSC
L	13.200	13.730	0.520	0.541
L1	3.100	3.500	0.122	0.138
n	6.050	6.150	0.238	0.242
ØΡ	3.050	3.450	0.120	0.136
u	2.400	2.500	0.094	0.098
V	0.400	0.500	0.016	0.020

ECN: X09-0126-Rev. B, 26-Oct-09 DWG: 5972

- To be used only for process drawing.
 These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
 All critical dimensions should C meet C_{pk} > 1.33.
- 4. All dimensions include burrs and plating thickness.5. No chipping or package damage.



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